

*Curriculum Vitae*  
**Thomas Schenkel**

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### **Research areas**

Exploration of spin qubits, materials far from equilibrium, radiation effects, accelerator technology

### **Experience**

- 2019 – present Interim Director, Accelerator Technology and Applied Physics Division (<http://atap.lbl.gov/>), Lawrence Berkeley National Laboratory, Berkeley, CA
- 2013 – present Physicist, Senior Scientist, Accelerator Technology and Applied Physics Division (<http://atap.lbl.gov/>), Lawrence Berkeley National Laboratory
- Deputy Division Director for Technology, ATAP (2017-2018)
  - Program Head, Fusion Science and Ion Beam Technology Program (since 2013), leading a diverse program with research on intense, pulsed ion beams (NDCX-II, BELLA-i), accelerator development, active nuclear interrogation, applied plasma science, radiation effects and explorations of quantum computer architectures, funded by DOE Office of Science, ArpaE, other agencies and companies
- 2009 – 2013 Group Leader, Ion Beam Technology Group, and Deputy Program Head, Fusion Science and Ion Beam Technology Program, LBNL
- 2002 – 2009 Staff Scientist, physicist, Accelerator & Fusion Research Division, LBNL
- PI of quantum computer development projects, leading a multi-disciplinary, multi-institutional team, funded by DOD
- 2000 – 2002 Physicist, Accelerator & Fusion Research Division, LBNL
- Member of the Spallation Neutron Source front end team
  - Established projects in solid state quantum computer development
- 1997 – 2000 Postdoctoral Fellow, Chemistry & Materials Science Department, Lawrence Livermore National Laboratory, Livermore, CA
- Ultrafast electronic excitation of solids, nano-structuring, materials analysis
- 1994 – 1997 Graduate student researcher, Physics & Space Technology Directorate, LLNL
- Ion-solid interaction physics with slow, very highly charged ions

### **Education**

- 1997 Ph.D. Physics, Goethe University, Institute of Nuclear Physics, Frankfurt/M, Germany  
1993 Diploma, Physics, Goethe University, Institute of Nuclear Physics, Frankfurt/M

### **Articles in Nature and Nature family journals**

1. A. J. Sigillito, J. Anthony, A. M. Tyryshkin, T. Schenkel, A. A. Houck, S. A. Lyon, "All-electric control of donor nuclear spin qubits in silicon", *Nature Nanotech.* 12, 958 (2017)
2. A. Bienfait, J. J. Pla, Y. Kubo, X. Zhou, M. Stern, C. C. Lo, C. D. Weis, T. Schenkel, D. Vion, D. Esteve, J. J. L. Morton, P. Bertet, "Controlling spin relaxation with a cavity", *Nature* 531, 74 (2016)

3. A. Bienfait, J. J. Pla, Y. Kubo, M. Stern, X. Zhou, C. C. Lo, C. D. Weis, T. Schenkel, M. Thewalt, D. Vion, D. Esteve, B. Julsgaard, K. Mølmer, J. Morton, and P. Bertet, “Reaching the quantum limit of sensitivity in electron spin resonance”, *Nature Nanotechnology* 11, 253 (2016)
4. A. M. Tyryshkin, S. Tojo, J. J. L. Morton, H. Riemann, N. V. Abrosimov, P. Becker, H. J. Pohl, T. Schenkel, M. L. W. Thewalt, K. M. Itoh, S. A. Lyon, “Electron spin coherence exceeding seconds in high-purity silicon”, *Nature Materials* 11, 143 (2012)
5. G. Fuchs, V. Dobrovitski , D. Toyli , J. Heremans , C. Weis, T. Schenkel, and D. D. Awschalom, “Excited-state spin coherence of a single nitrogen-vacancy centre in diamond”, *Nature Physics* 6, 668 (2010)
6. J. J. L. Morton, A. M. Tyryshkin, R. M. Brown, S. Shankar, B. W. Lovett, A. Ardavan, T. Schenkel, E. E. Haller, J. W. Ager, and S. A. Lyon, “Solid state quantum memory using the  $^{31}\text{P}$  nuclear spin”, *Nature* 455, 1085 (2008)

### **Articles in Physical Review Letters**

1. Dong-Xia Qu, N. E. Teslich, Z. R. Dai, G. F. Chapline, T. Schenkel, S. R. Durham, J. Dubois, “Onset of a Two-Dimensional Superconducting Phase in a Topological-Insulator-Normal-Metal  $\text{Bi}_{1-x}\text{Sbx}/\text{Pt}$  Junction Fabricated by Ion-Beam Techniques”, *Phys. Rev. Lett.* 121, 037001 (2018)
2. C. C. Lo, C. D. Weis, J. van Tol, J. Bokor, T. Schenkel, “All electrical nuclear spin polarization of donors in silicon”, *Phys. Rev. Lett.*, 110, 057601 (2013)
3. C. C. Lo, V. Lang, R. E. George, J. J. L. Morton, A. M. Tyryshkin, S. A. Lyon, J. Bokor, T. Schenkel, “Electrically detected magnetic resonance of neutral donors interacting with a two-dimensional electron gas”, *Phys. Rev. Lett.* 106, 207601 (2011)
4. G. D. Fuchs, V. V. Dobrovitski, R. Hanson, A. Batra, C. D. Weis, T. Schenkel, and D. D. Awschalom, “Excited state spectroscopy using single spin manipulation in diamond“, *Phys. Rev. Lett.* 101, 117601 (2008)
5. F. R. Bradbury, A. M. Tyryshkin, G. Sabouret, J. Bokor, T. Schenkel, and S. A. Lyon, “Stark Tuning of Donor Electron Spins in Silicon”, *Phys. Rev. Lett.* 97, 176404 (2006)
6. T. Schenkel, A. V. Barnes, T. R. Niedermayr, M. Hattass, M. W. Newman, G. A. Machicoane, J. W. McDonald, A. V. Hamza, and D. H. Schneider, “Deposition of potential energy in solids by slow, highly charged ions”, *Phys. Rev. Lett.* 83, 4273 (1999)
7. M. Hattass, T. Schenkel, A. V. Hamza, A. V. Barnes, M. W. Newman, J. W. McDonald, T. R. Niedermayr, G. A. Machicoane, and D. H. Schneider, “Charge Equilibration time of slow, highly charged ions in solids”, *Phys. Rev. Lett.* 82, 4795 (1999)
8. T. Schenkel, A. V. Barnes, A. V. Hamza, J. C. Banks, B. L. Doyle, D. H. Schneider: “Synergy of electronic excitation and elastic collision spikes in sputtering of heavy metal oxides”, *Phys. Rev. Lett.* 80, 4325 (1998)
9. T. Schenkel, A. V. Hamza, A. V. Barnes, J. C. Banks, B. L. Doyle, D. H. Schneider: “Ablation of GaAs by intense, ultrafast electronic excitation from highly charged ions”, *Phys. Rev. Lett.* 81, 2590 (1998)
10. T. Schenkel, M. A. Briere, A. V. Barnes, A. Hamza, K. Bethge, H. Schmidt-Böcking, D. H. Schneider: “Charge State Dependent Energy Loss of Slow Heavy Ions in Solids”, *Phys. Rev. Lett.* 79,2030 (1997)
11. T. Schenkel, M. A. Briere, H. Schmidt-Böcking, K. Bethge, D. H. Schneider, “Electronic Sputtering of Thin Conductors by Neutralization of Slow Highly Charged Ions”, *Phys. Rev. Lett.* 78, 2481 (1997)

### **Patents**

1. WO2017192834A1, “Wafer-based charged particle accelerator, wafer components, methods, and applications”, A. Lal, T. Schenkel, A. Persaud, Q. Ji, P. Seidl, W. Waldron, S. Ardanuc, V. K. B. Kumar, Nov. 2017
2. US 9484176 B2, “Advanced Penning Ion Source”, T. Schenkel, Q. Ji, A. Persaud, A. V. Sy,

Nov. 01, 2016

3. US 9161429 B2, "Compact ion source neutron generator", T. Schenkel, A. Persaud, R. Kapadia, A. Javey, C. Chang-Hasnain, I. Rangelow, J. Kwan, date of patent: Oct. 13, 2015
4. US 8709350, "Compact ion acceleration source", T. Schenkel, A. Persaud, R. Kapadia, A. Javey, April 29, 2014
5. US 20130087766, "Scalable quantum computer architecture with coupled donor-quantum dot qubits", T. Schenkel, C. C. Lo, C. Weis, S. Lyon, A. Tyryshkin, J. Bokor, April 11, 2013
6. US7750297, "Carbon Nanotube Collimator Fabrication and Application", Lee Chow, Guangyu Chai, Thomas Schenkel, Jul. 6, 2010
7. US7126139, "Device and method of positionally accurate implantation of individual particles in a substrate surface", T. Schenkel, I. Rangelow, J. Meijer, Oct. 24, 2006
8. US6291820, "Highly charged ion secondary ion mass spectrometry", A. V. Hamza, T. Schenkel, A. V. Barnes, D. H. Schneider, Sept. 18, 2001
9. US6288394, "Highly charged ion based time of flight emission microscope", A. V. Barnes, T. Schenkel, A. V. Hamza, D. H. Schneider, and B. L Doyle, Sept. 11, 2001

### **Teaching**

- Lecturer at UC Berkeley, Nuclear Engineering, teaching NE-282, Spring 2018, "Beam physics and Accelerators" (for graduate students)
- Pan American Advanced Study Institute "Ion Nanobeams", Buenos Aires, Argentina, 02/2006
- supervising (under)-graduate students (physics, nuclear and electrical engineering) since 2000
- guest lectures on topics of quantum computer development, nanotechnology and accelerator technology at UC Berkeley since 2000

### **Selected Service**

- Chair, Fusion Energy Sciences Roundtable on Quantum Information Science, May 2019, <https://science.energy.gov/fes/community-resources/workshop-reports/>
- International Atomic Energy Agency (IAEA), international program advisory committee, radiation effects, 2015-2016
- High Energy Density Science Association, HEDSA, vice-chair, 2015-2016
- Topic editor at the International Conference on Applications of Accelerators in Research and Industry; Focused Ion Beams and Nanotechnology, 21<sup>st</sup> CAARI, August 2010; Accelerator Technology, 23<sup>rd</sup> CAARI, August 2014; 24<sup>th</sup> CAARI, Nov. 2016, 26<sup>th</sup> CAARI, Aug. 2018
- International scientific advisory committee, International Conference on Atomic Collisions in Solids (ICACS), since 2012
- Chair, International workshop on Silicon Qubits, Berkeley, August 24-25, 2009
- User Executive Committee, The Molecular Foundry, LBNL, member (2007-2010), committee chair and chair of annual users' meeting (2008)

### **Selected honors**

- Chemistry & Materials Science Directorate Award, Lawrence Livermore National Laboratory, 2000
- Student Prize of the Heraeus Foundation, 1993

### **Selected invited presentations:**

1. "Accessing the dynamics of radiation induced defects in materials", International Atomic Energy Agency, Technical Meeting on Radiation Effects, Torino, May 2016
2. "Tailoring of materials properties under extreme conditions", APS March Meeting, Baltimore, March 16, 2016
3. "Local Formation of Nitrogen Vacancy Centers in Diamond by Electronic Excitation", Material Research Society, Spring Meeting, San Francisco, April 08, 2015

4. "Deterministic doping and the exploration of spin qubits", Gordon Research Conference on Nanostructure Fabrication, University of New England, Biddeford, ME, July 13-18, 2014,
5. "Formation of quantum computer test structures in silicon and diamond", International Conference on Applied Atom Optics, Bad Honnef, Germany, July 27-29, 2009
6. "Formation of quantum computer test structures by ion implantation with scanning probe alignment", 23<sup>rd</sup> International Conference on Atomic Collisions in Solids, ICACS 23, Phalaborwa, South Africa, August 17-22, 2008
7. "Single atom doping and single atom device development", 52<sup>nd</sup> International Conference on Electron, Ion and Photon Beams and Nanofabrication, Portland, OR, May 29, 2008
8. "Ion Implantation with Scanning Probe Alignment", 15<sup>th</sup> International Conference on Ion Beam Modification of Materials, IBMM, Taormina, Italy, September 2006
9. "Integration of scanning probes with ion beams and the development of coherent electronic devices", International Conference on Nanoscience & Nanotechnology, ICONN, Brisbane, Australia, July 2006
10. "Epitaxial integration of spin qubits in silicon", 14<sup>th</sup> International Conference on Ion Beam Modification of Materials, IBMM, Monterey, CA, Sept. 2004

### **General audience articles and features**

- "A resonant circuit accelerates spontaneous spin-flip transitions", J. L. Miller, Physics Today March 2016, P. 16, [link](#)
- "A New Spin on Quantum Computing: Scientists Train Electrons with Microwaves", Berkeley Lab News, Feb 15, 2016, [link](#)
- C. D. Weis and T. Schenkel, "Single spins in silicon see the light", Nature 497, 46 (2013)
- Berkeley Lab video glossary "Quantum Computing", <http://videoglossary.lbl.gov/2009/quantum-computing/>, [link](#)
- "News Bits About Qubits: Scientists Store and Retrieve Data Inside an Atom", Berkeley Lab News, Oct. 23, 2008
- "A Toolkit for Silicon-based Quantum Computing", Berkeley Lab News, Oct. 22, 2008, [link](#)
- "Making Quantum Computing Work in Silicon", Berkeley Lab News, May 30, 2006
- "Aligned implantation via integrated scanning probe", Materials Today, News, P.10, July 2005
- T. Schenkel, "Reliable Performance", Nature Materials 4, 799 (2005)
- Lee Gomes, "Quantum Computing may seem too far out, but don't count on it", Wall Street Journal, page B1, April 25, 2005

### **Book chapters**

1. M. DeWitt, T. Schenkel, A. Yildiz, "Fluorescence tracking of motor proteins in vitro", 2014, in "Fluorescent Methods for Molecular Motors", Pages 211-234, Publisher: Springer Basel
2. T. Schenkel, C. C. Lo, C. D. Weis, J. Bokor, A. M. Tyryshkin, S. A. Lyon, "A spin quantum bit architecture with coupled donors and quantum dots in silicon", in "Single Atom Nanoelectronics", Pan Stanford Publishing, ISBN-13: 978-9814316316 (2013), arXiv:1110.2228
3. "Single Ion Implantation", in "Nanofabrication Handbook", S. Cabrini and S. Kawata (eds.), Taylor & Francis – CRC Press, ISBN: 978-1-4200-9052-9, P. 340 – 350 (2012)
4. "Surface Analysis with Slow, Highly Charged Ions: TOF-SIMS and the Probing of Nano-environments", in "Ion Beam Analysis of Surfaces and Interfaces" (Nova, New York, 2003), P. Chakraborty (ed.), P. 267 – 310
5. "Physics at the Electron Beam Ion Trap", D. H. G. Schneider, J. Steiger, T. Schenkel, and J. R. Crespo Lopez-Urrutia, in "Atomic Physics with Heavy Ions", H. F. Beyer and V. P. Shevelko (eds.), (Springer, Berlin, 1999), P. 30 - 59

### **Review articles**

1. S. Henderson, ..., T. Schenkel, ..., et al., "The Spallation Neutron Source accelerator system

- design”, Nucl. Instr. Meth. A 763, 610 (2014)
2. W. J. Moberly Chan, D. P. Adams, M. J. Aziz, G. Hobler, T. Schenkel, "Fundamentals of Focused Ion Beam Nanostructural Processing", MRS Bulletin Vol. 32 (5), 424 (2007)
  3. T. Schenkel, A. Persaud, S. J. Park, J. Nilsson, J. Bokor, J. A. Liddle, R. Keller, D. H. Schneider, D. W. Cheng, and D. E. Humphries, “Solid state quantum computer development in silicon with single ion implantation”, J. Appl. Phys. (Applied Physics Review) 94, 7017 (2003)
  4. T. Schenkel, A. V. Hamza, A. V. Barnes, and D. H. Schneider, “Interaction of slow, very highly charged ions with surfaces”, Prog. Surf. Science 61, 23 (1999)

**Articles (h-index: 29, web of science; 33, Google scholar)**

1. Dong-Xia Qu, N. E. Teslich, Z. R. Dai, G. F. Chapline, T. Schenkel, S. R. Durham, J. Dubois, “Onset of a Two-Dimensional Superconducting Phase in a Topological-Insulator-Normal-Metal Bi<sub>1-x</sub>Sbx/Pt Junction Fabricated by Ion-Beam Techniques”, Phys. Rev. Lett. 121, 037001 (2018)
2. F. Treffert, Q. Ji, P. A. Seidl, A. Persaud, B. Ludewigt, J. J. Barnard, A. Friedman, D. P. Grote, E. P. Gilson, I. D. Kaganovich, A. Stepanov, M. Roth, T. Schenkel, “Design and implementation of a Thomson parabola for fluence dependent energy-loss measurements at the Neutralized Drift Compression eXperiment”, Rev. Sci. Instr. 89, 103302 (2018)
3. P.A. Seidl, A. Persaud, W. Ghiorso, Q. Ji, W.L. Waldron, A. Lal, K.B. Vinayakumar, T. Schenkel, “Source-to-accelerator quadrupole matching section for a compact linear accelerator”, Rev. Sci. Instr. 89, 053302 (2018),
4. Anton D. Stepanov, Erik P. Gilson, Igor D. Kaganovich, Peter A. Seidl, Arun Persaud, Qing Ji, Thomas Schenkel, Alex Friedman, John J. Barnard, David P. Grote, “Optimizing Beam Transport in Rapidly Compressing Beams on the Neutralized Drift Compression Experiment – II”, arXiv:1711.00539, Matter and Radiation at Extremes 3, 78 (2018)
5. Lake, R. E., A. Mueller, H. Pan, A. Persaud, B. A. Ludewigt, V. Z. Kresin, A. M. Minor, P. A. Seidl, and T. Schenkel. 2017. “Patterned Electron Beam Exposures of YBCO – Towards Local Control of Doping.” Physics Procedia 90, 381–84 (2018),
6. B. A. Ludewigt, P.A. Seidl, A. Persaud, Q. Ji, S. Steinke, S.S. Bulanov, K. Nakamura, W.P. Leemans, T. Schenkel, E.S. Bielejec, A. Friedman, D.P. Grote, and J.J. Barnard, “Short Intense Ion Pulses for Radiation Effects Research Using NDCX-II and BELLA-i”, Journal of Radiation Effects, research and Engineering (JRERE) V 36, 96 (2018), available upon request
7. J. J. Barnard and T. Schenkel, “Modeling of intense pulsed ion beam heated masked targets for extreme materials characterization”, J. of Appl. Phys. 122, 195901 (2017)
8. S. Probst, A. Bienfait, P. Campagne-Ibarcq, J. J. Pla, B. Albanese, J. F. D. Barbosa, J. F. Da Silva, T. Schenkel, D. Vion, D. Esteve, K. Moelmer, J. J. L. Morton, R. Heeres, P. Bertet, “Inductive-detection electron-spin resonance spectroscopy with 65 spins/root Hz sensitivity”, Appl. Phys. Lett. 111, 202604 (2017)
9. A. Bienfait, P. Campagne-Ibarcq, A. H. Kiilerich, X. Zhou, S. Probst, J. J. Pla, T. Schenkel, D. Vion, D. Esteve, J. J. L. Morton, K. Moelmer, P. Bertet, “Magnetic Resonance with Squeezed Microwaves”, Phys. Rev. X 7, 041011 (2017)
10. A. J. Sigillito, J. Anthony, A. M. Tyryshkin, T. Schenkel, A. A. Houck, S. A. Lyon, ”All-electric control of donor nuclear spin qubits in silicon”, Nature Nanotech. 12, 958 (2017)
11. J.J. Pla, A. Bienfait, G. Pica, J. Mansir, F.A. Mohiyaddin, A. Morello, T. Schenkel, B.W. Lovett, J.J.L. Morton, P. Bertet, “Strain-induced nuclear quadrupole splittings in silicon devices”, Phys. Rev. Applied 9, 044014 (2018)
12. A. T. Asfaw, A. J. Sigillito, A. M. Tyryshkin, T. Schenkel, S. A. Lyon, “Multi-frequency spin manipulation using rapidly tunable superconducting coplanar waveguide microresonators”, Appl. Phys. Lett. 111, 032601 (2017)
13. P.A. Seidl, Q. Ji, A. Persaud, E. Feinberg, B. Ludewigt, M. Silverman, A. Sulyman, W.L. Waldron, T. Schenkel, J.J. Barnard, A. Friedman, D.P. Grote, E.P. Gilson, I.D. Kaganovich, A.D. Stepanov, F. Treffert, M. Zimmer, “Irradiation of Materials with Short, Intense Ion

- pulses at NDCX-II”, Lasers and Particle Beams 35, 373 (2017)
14. A. Persaud, P. A. Seidl, Q. Ji, E. Feinberg, W. L. Waldron, T. Schenkel, S. Ardanuc, K. B. Vinayakumar, A. Lal, “Staging of RF-accelerating units in a MEMS-based ion accelerator”, arXiv:1702.00460, Physics Procedia 90, 2017, Pages 136-142
  15. A. Persaud, Q. Ji, E. Feinberg, P. A. Seidl, W. L. Waldron, A. Lal, K. B. Vinayakumar, S. Ardanuc, D. A. Hammer, and T. Schenkel, ”A compact linear accelerator based on a scalable micro-electromechanical-system RF-structure”, Rev. Sci. Instr. 88, 063304 (2017)
  16. Q. Ji, C. J. Lin, C. Tindall, M. Garcia-Sciveres, T. Schenkel, B. A. Ludewigt, “Coincidence measurements of He-3 and neutrons from a compact D-D neutron generator”, Rev. Sci. Instr. 88, 056105 (2017)
  17. B. C. Rose, C. D. Weis, A. M. Tyryshkin, T. Schenkel, S. A. Lyon, “Spin Coherence and 14-N ESEEM Effects of Nitrogen-Vacancy Centers in Diamond with X-band Pulsed ESR”, Diamond and related Materials 72, 32 (2017)
  18. A. Koniges, W. Liu, S. Lidia, T. Schenkel, J. Barnard, A. Friedman, D. Eder, A. Fisher, N. Masters, “Numerical Modeling of Complex Targets for High-Energy- Density Experiments with Ion Beams and other Drivers”, J. Phys.: Conf. Series 688 (2016) 012053
  19. A. Bienfait, J. J. Pla, Y. Kubo, X. Zhou, M. Stern, C. C. Lo, C. D. Weis, T. Schenkel, D. Vion, D. Esteve, J. J. L. Morton, and P. Bertet, “Controlling spin relaxation with a cavity”, Nature 531 ,74 (2016)
  20. G. Pica, B. W. Lovett, R. N. Bhatt, T. Schenkel, S. A. Lyon, “Surface code architecture for donors and dots in silicon with imprecise and non-uniform qubit couplings”, Phys. Rev. B 93, 035306 (2016)
  21. P. A. Seidl, J. J Barnard, R. C. Davidson, A. Friedman, E. P. Gilson, D. Grote, Q. Ji, I. D. Kaganovich, A. Persaud, W. L. Waldron, T. Schenkel, “Short-Pulse, Compressed Ion Beams at the Neutralized Drift Compression Experiment”, Journal of Physics, Conference Series 717, 012079 (2016)
  22. A. Bienfait, J. J. Pla, Y. Kubo, M. Stern, X. Zhou, C. C. Lo, C. D. Weis, T. Schenkel, M. Thewalt, D. Vion, D. Esteve, B. Julsgaard, K. Mølmer, J. Morton, and P. Bertet, “Reaching the quantum limit of sensitivity in electron spin resonance”, Nature Nanotechnology 11, 253 (2016)
  23. Q. Ji, P. A. Seidl, W. L. Waldron, J. H. Takakuwa, A. Friedman, D. P. Grote, A. Persaud, J. J. Barnard, and T. Schenkel, “Development and testing of a pulsed helium ion source for probing materials and warm dense matter studies”, Rev. Sci. Instr. 87, 02B707 (2016)
  24. P. A. Seidl, W. G. Greenway, S. M. Lidia, A. Persaud, M. Stettler, J. H. Takakuwa, W. L. Waldron, T. Schenkel, J. J. Barnard, A. Friedman, D. P. Grote, R. C. Davidson, E. P. Gilson, I. D. Kaganovich, “Short intense ion pulses for materials and warm dense matter research”, Nucl. Instr. Meth. A 800, 98 (2015), arXiv:1506.05839
  25. A. Persaud, J. J. Barnard, H. Guo, P. Hosemann, S. Lidia, A. M. Minor, P. A. Seidl, and T. Schenkel, “Accessing defect dynamics using intense, nanosecond pulsed ion beams”, Physics Procedia 66, 604 (2015), arXiv:1409.2565
  26. T. Schenkel, C. D. Weis, C. C. Lo, A. Persaud, I. Chakarov, D. H. Schneider, and J. Bokor, “Deterministic Doping and the Exploration of Spin Qubits”, Proceedings of the XII International Symposium on Electron Beam Ion Sources and Traps, AIP Conf. Proc. 1640, 124 (2015)
  27. J. Schwartz, S. Aloni, D. F. Ogletree, M. Tomut, M. Bender, D. Severin, C. Trautmann, I. W. Rangelow, and T. Schenkel, “Local formation of nitrogen-vacancy centers in diamond by swift heavy ions”, J. Appl. Phys. 116, 214107 (2014)
  28. Hua Guo, Arun Persaud, Steve Lidia, Andrew M. Minor, P. Hosemann, Peter A. Seidl, and Thomas Schenkel, “Dynamic investigation of defects induced by short, high current pulses of high energy lithium ions”, Mater. Res. Soc. Symp. Proc. Vol. 1712, DOI: 10.1557/opl.2014.856
  29. Saleem G. Rao, Altaf Karim, Julian Schwartz, Natania Antler, Thomas Schenkel, and Irfan Siddiqi, Directed Assembly of Nanodiamond Nitrogen-Vacancy Centers on a Chemically

- Modified Patterned Surface”, ACS Appl. Mater. Interfaces 6, 12893 (2014)
30. A. R. Schmidt, E. Henry, C. C. Lo, Y.-T. Wang, H. Li, L. Greenman, O. Namaan, T. Schenkel, K. B. Whaley, J. Bokor, E. Yablonovitch, and I. Siddiqi, “A prototype silicon double quantum dot with dispersive microwave readout”, J. Appl. Phys. 116, 044503 (2014)
  31. C. C. Lo, S. Simmons, R. Lo Nardo, C. D. Weis, A. M. Tyryshkin, J. Meijer, D. Rogalla, S. A. Lyon, J. Bokor, T. Schenkel, J. J. L. Morton, “Stark shift and field ionization of arsenic donors in  $^{28}\text{Si}$ -SOI structures”, Appl. Phys. Lett. 104, 193502 (2014), arXiv:1401.6885
  32. T. Schenkel, S. M. Lidia, C. D. Weis, W. L. Waldron, J. Schwartz, A. M. Minor, P. Hosemann, J. W. Kwan, “Towards pump-probe experiments of defect dynamics with short ion beam pulses”, Nucl. Instr. Meth. B 315, 350, (2013), <http://arxiv.org/abs/1211.6385>
  33. C. C. Lo, C. D. Weis, J. van Tol, J. Bokor, T. Schenkel and J. J. L. Morton, “Spins in silicon MOSFETs: Electron spin relaxation and hyperpolarization of nuclear spins”, Proceedings of SPIE Vol. 8813, 2X-1, Spintronics VI, 2013
  34. T. N. Makgatoa, E. Sideras-Haddad, S. Shrivastavaa, T. Schenkel, R. Ritter, G. Kowarik, F. Aumayr, J. Crespo López-Urrutia, S. Bernitt, C. Beilmann, R. Ginzel, “Highly charged ion impact induced nanodefects in diamond”, Nucl. Instr. Meth. B 314, 135 (2013)
  35. A. Sy, Q. Ji, A. Persaud, B. A. Ludewigt and T. Schenkel, “Ion Source and Beam Guiding Studies for an Associate Particle Imaging Neutron Generator”, in: Applications of Accelerator in Research and Industry, AIP Conf. Proc. 1525, 123 (2013)
  36. O. Waldmann, A. Persaud, R. Kapadia, K. Takei, F. I. Allen, A. Javey, T. Schenkel, “Effects of palladium coating on field-emission properties of carbon nanofibers in a hydrogen plasma”, Thin Solid Films 534, 488 (2013)
  37. C. C. Lo, C. D. Weis, J. van Tol, J. Bokor, T. Schenkel, “All electrical nuclear spin polarization of donors in silicon”, Phys. Rev. Lett., 110, 057601 (2013)
  38. M. Ilg, C. D. Weis, J. Schwartz, A. Persaud, Q. Ji, C. C. Lo, J. Bokor, A. Hegyi, E. Guliyev, I. W. Rangelow, T. Schenkel, “Improved single ion implantation with scanning probe alignment”, J. Vac. Sci. Techn. B 30, 06FD04 (2012)
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